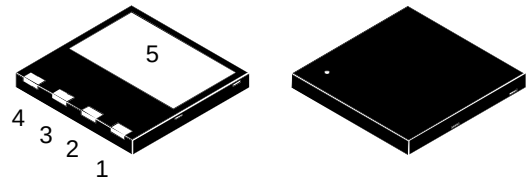
STL57N65M5

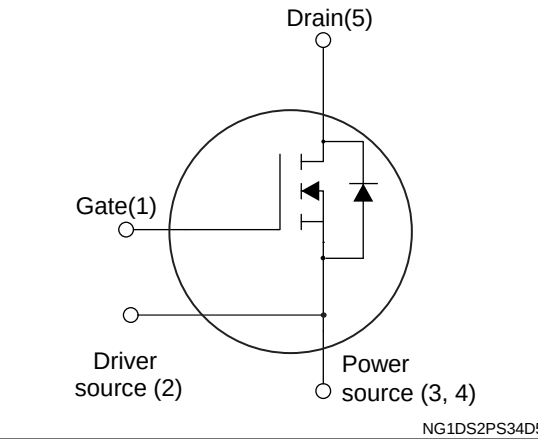
N-channel 650 V, 0.061 Ω typ., 22.5 A MDmesh™ M5 Power MOSFET in a PowerFLAT™ 8x8 HV package

Datasheet - production data



PowerFLAT™ 8x8 HV

Figure 1: Internal schematic diagram



Features

Order code	V_{DS} @ T_{Jmax}	$R_{DS(on)}$ max.	I_D
STL57N65M5	710 V	0.069Ω	22.5 A

- Extremely low $R_{DS(on)}$
- Low gate charge and input capacitance
- Excellent switching performance
- 100% avalanche tested

Applications

- Switching applications

Description

This device is an N-channel Power MOSFET based on the MDmesh™ M5 innovative vertical process technology combined with the well-known PowerMESH™ horizontal layout. The resulting product offers extremely low on-resistance, making it particularly suitable for applications requiring high power and superior efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STL57N65M5	57N65M5	PowerFLAT™ 8x8 HV	Tape and reel

Contents

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage	650	V
V_{GS}	Gate-source voltage	± 25	V
I_D (1)	Drain current (continuous) at T_C = 25 °C	22.5	A
I_D (1)	Drain current (continuous) at T_C = 100 °C	22	A
I_{DM} (1)(2)	Drain current (pulsed)	90	A
I_D (3)	Drain current (continuous) at T_{pcb} = 25 °C	4.3	A
I_D (3)	Drain current (continuous) at T_{pcb} = 100 °C	2.7	A
P_{TOT} (3)	Total dissipation at T_{pcb} = 25 °C	2.8	W
P_{TOT} (1)	Total dissipation at T_C = 25 °C	189	W
I_{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by Tj max)	9	A
E_{AS}	Single pulse avalanche energy (starting T_j = 25 °C, I_D = I_{AR}, V_{DD} = 50 V)	960	mJ
dv/dt (4)	Peak diode recovery voltage slope	15	V/ns
T_{stg}	Storage temperature	- 55 to 150	°C
T_j	Max. operating junction temperature	150	

Notes:

(1)The value is rated according to $R_{thj\text{-}case\ rated}$ and limited by package.

(2)Pulse width limited by safe operating area.

(3)When mounted on FR-4 board of 1 inch² , 2oz Cu.

(4)I_{SD} ≤ 22.5 A, di/dt ≤ 400 A/µs; $V_{DS(peak)}$ < $V_{(BR)DSS}$, V_{DD} = 400 V.

Table 3: Thermal data

Symbol	Parameter	Value	Unit
$R_{thj\text{-}case}$	Thermal resistance junction-case max	0.66	°C/W
$R_{thj\text{-}pcb}$ (1)	Thermal resistance junction-pcb max	45	°C/W

Notes:

(1)When mounted on FR-4 board of 1 inch², 2oz Cu.

2 Electrical characteristics

T_C = 25 °C unless otherwise specified

Table 4: On/off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	V_{GS} = 0 V, I_D = 1 mA	650			V
I_{DSS}	Zero gate voltage Drain current	V_{GS} = 0 V, V_{DS} = 650 V			1	µA
		V_{GS} = 0 V, V_{DS} = 650 V, T_C= 125 °C			100	µA
I_{GSS}	Gate-body leakage current	V_{GS} = ± 25 V, V_{DS}= 0 V			±100	nA
$V_{GS(th)}$	Gate threshold voltage	V_{DS} = V_{GS}, I_D = 250 µA	3	4	5	V
$R_{DS(on)}$	Static drain-source on-resistance	V_{GS} = 10 V, I_D = 17.5 A		0.061	0.069	Ω

Table 5: Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{iss}	Input capacitance	V_{DS}= 100 V, f = 1 MHz, V_{GS} = 0 V	-	4200	-	pF
C_{oss}	Output capacitance		-	100	-	pF
C_{rss}	Reverse transfer capacitance		-	6	-	pF
$C_{o(er)}$ (1)	Equivalent output capacitance energy related	V_{GS} = 0 V , V_{DS}= 0 to 80% $V_{(BR)DSS}$	-	97	-	pF
$C_{o(tr)}$ (2)	Equivalent output capacitance time related		-	344	-	pF
R_G	Intrinsic gate resistance	f = 1 MHz, I_D= 0 A	-	1.4	-	Ω
Q_g	Total gate charge	V_{DD} = 520 V, I_D = 17.5 A, V_{GS} = 10 V (see *Figure 15: "Gate charge test circuit"*)	-	96	-	nC
Q_{gs}	Gate-source charge		-	24	-	nC
Q_{gd}	Gate-drain charge		-	40	-	nC

Notes:

(1)$C_{o(er)}$ is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

(2)$C_{o(tr)}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 6: Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(V)}$	Voltage delay time	V_{DD} = 400 V, I_D = 22.5 A R_G = 4.7 Ω, V_{GS} = 10 V (see *Figure 16: " Test circuit for inductive load switching and diode recovery times"*and *Figure 19: "Switching time waveform"*)	-	84	-	ns
$t_{r(V)}$	Voltage rise time		-	10.8	-	ns
$t_{f(i)}$	Crossing fall time		-	11	-	ns
$t_{C(off)}$	Crossing time		-	16.5	-	ns

Table 7: Source drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SD} (1)	Source-drain current		-		22.5	A
I_{SDM} (1), (2)	Source-drain current (pulsed)		-		90	A
V_{SD} (3)	Forward on voltage	V_{GS} = 0 V, I_{SD} = 22.5 A	-		1.5	V
t_{rr}	Reverse recovery time	I_{SD} = 22.5 A, di/dt = 100 A/µs, V_{DD} = 100 V (see *Figure 16: " Test circuit for inductive load switching and diode recovery times"*)	-	378		ns
Q_{rr}	Reverse recovery charge		-	7		µC
I_{RRM}	Reverse recovery current		-	37		A
t_{rr}	Reverse recovery time	I_{SD} = 22.5 A, di/dt = 100 A/µs, V_{DD} = 100 V, T_j = 150 °C (see *Figure 16: " Test circuit for inductive load switching and diode recovery times"*)	-	454		ns
Q_{rr}	Reverse recovery charge		-	9.5		µC
I_{RRM}	Reverse recovery current		-	42		A

Notes:

(1)The value is rated according to $R_{thj\text{-}case}$ and limited by package.

(2)Pulse width is limited by safe operating area

(3)Pulsed: pulse duration = 300 µs, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2: Safe operating area

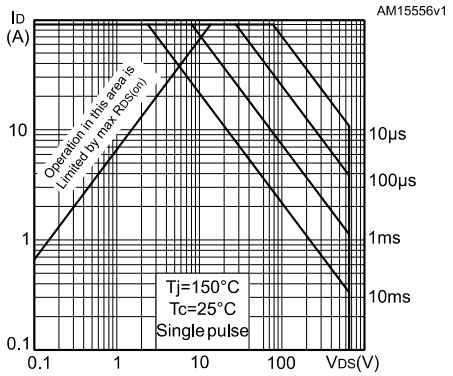


Figure 3: Thermal impedance

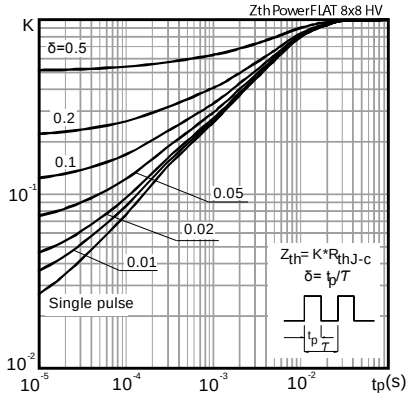


Figure 4: Output characteristics

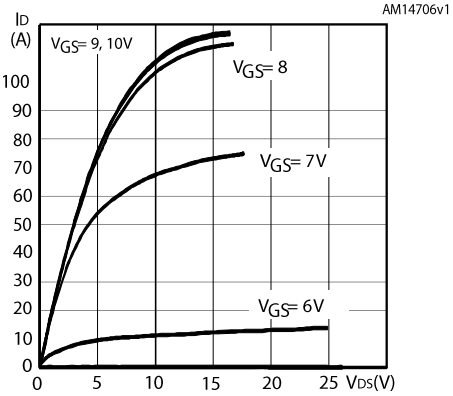


Figure 5: Transfer characteristics

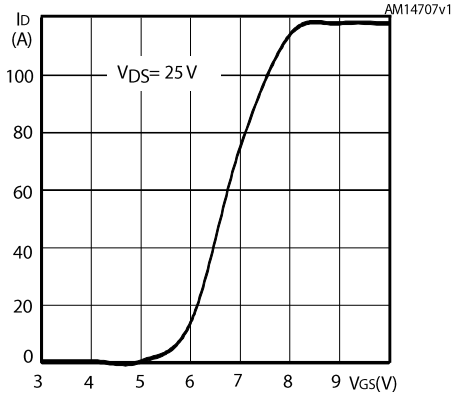


Figure 6: Gate charge vs gate-source voltage

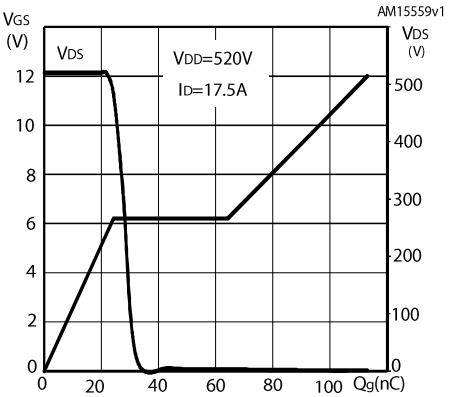


Figure 7: Static drain-source on-resistance

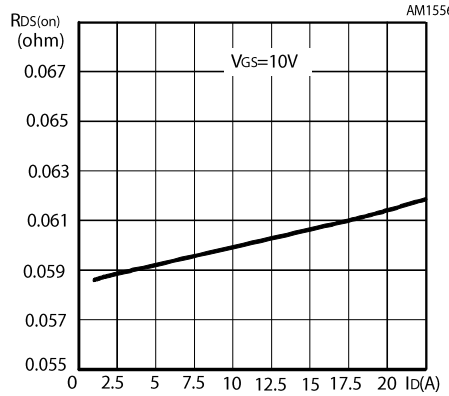


Figure 8: Capacitance variations

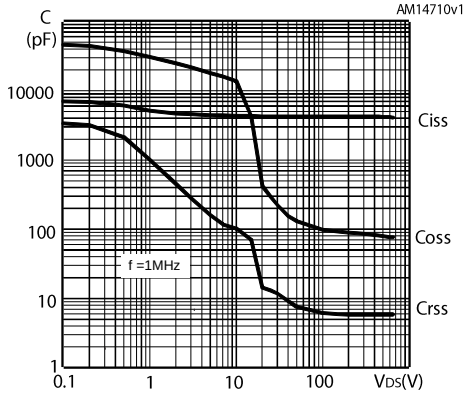


Figure 9: Normalized gate threshold voltage vs temperature

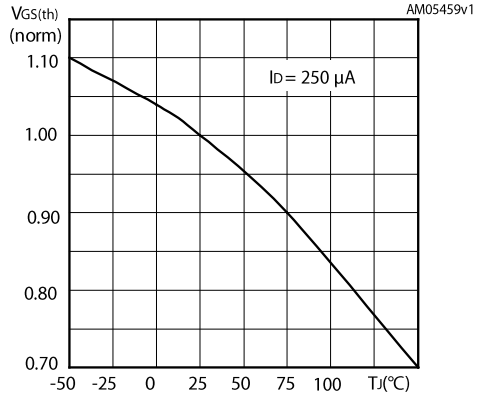


Figure 10: Normalized on-resistance vs temperature

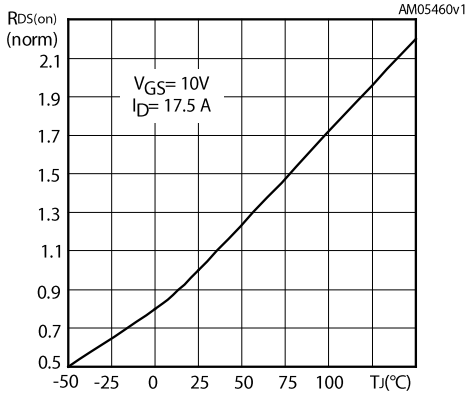


Figure 11: Normalized V(BR)DSS vs temperature

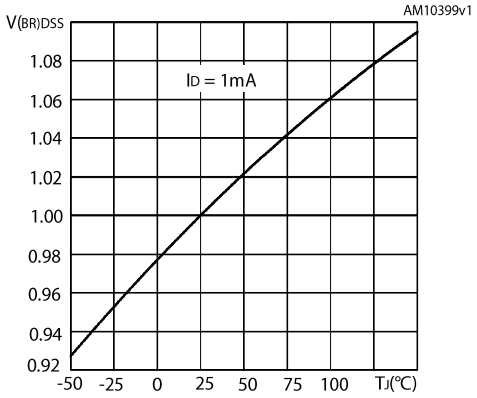


Figure 12: Output capacitance stored energy

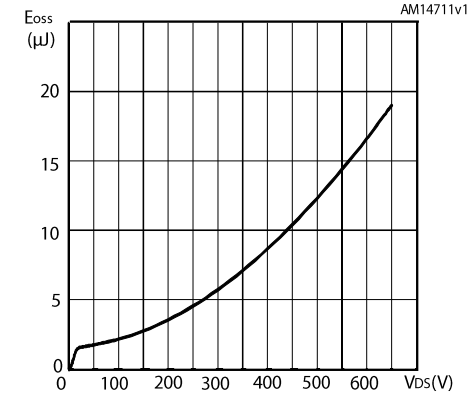
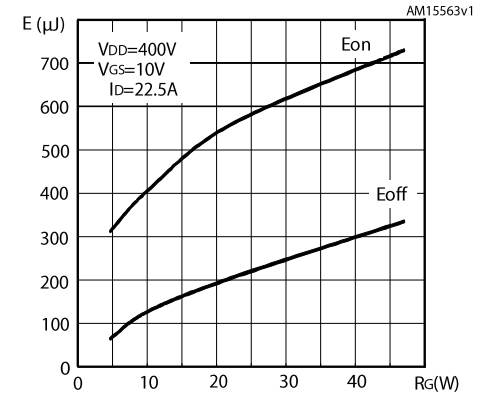


Figure 13: Switching losses vs gate resistance



The previous figure E_{on} includes reverse recovery of a SiC diode.

3 Test circuits

Figure 14: Switching times test circuit for resistive load

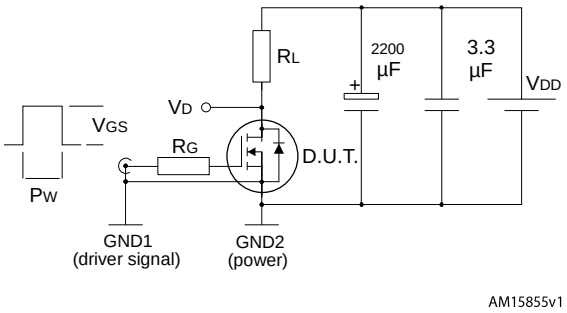


Figure 15: Gate charge test circuit

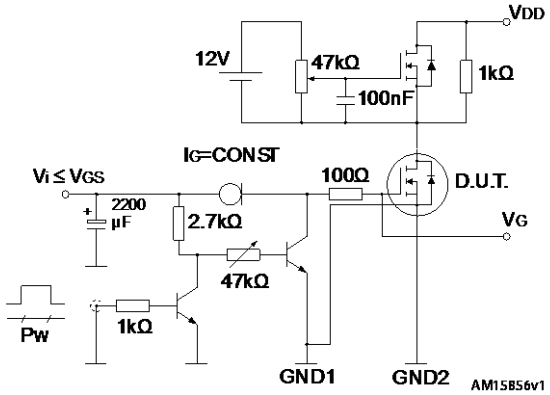


Figure 16: Test circuit for inductive load switching and diode recovery times

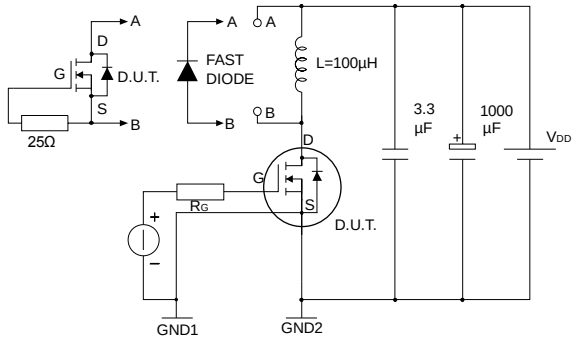


Figure 17: Unclamped inductive load test circuit

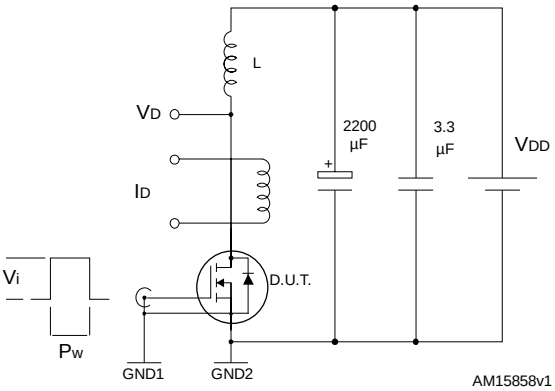


Figure 18: Unclamped inductive waveform

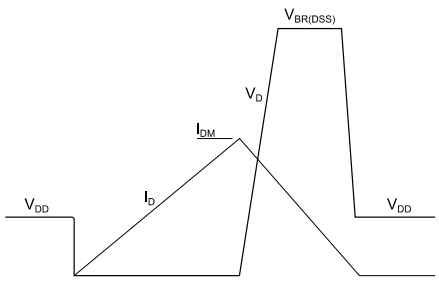
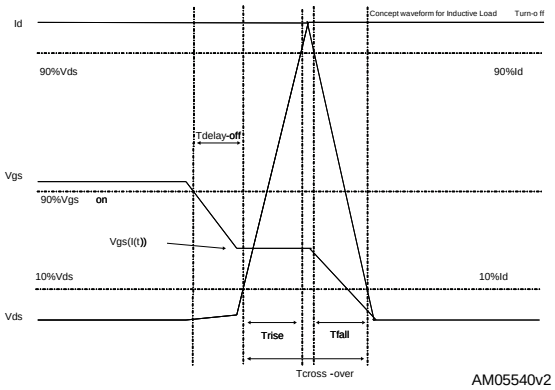


Figure 19: Switching time waveform



4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: ***www.st.com***. ECOPACK® is an ST trademark.

4.1 PowerFLAT™ 8x8 HV package information

Figure 20: PowerFLAT™ 8x8 HV drawing

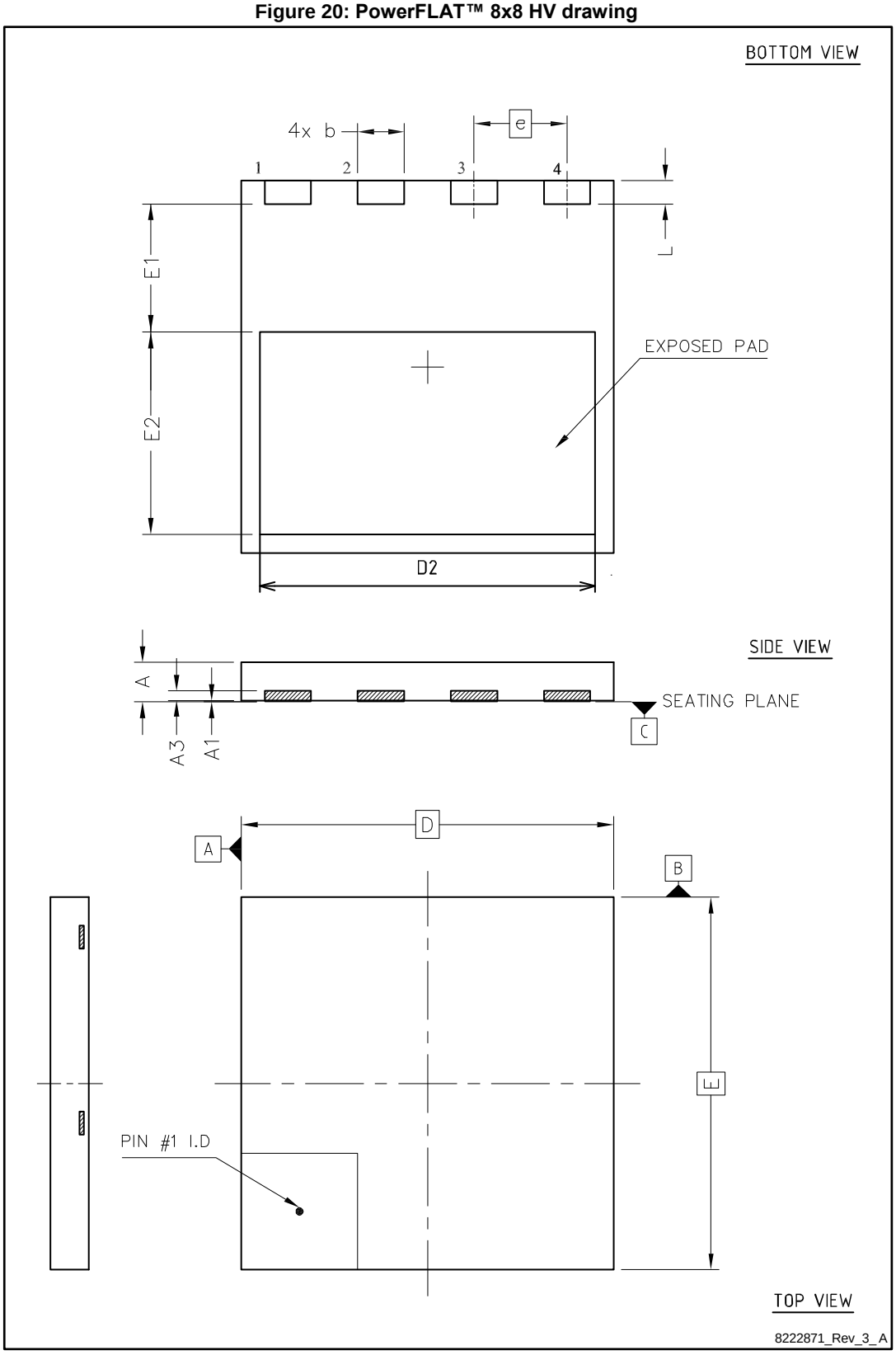
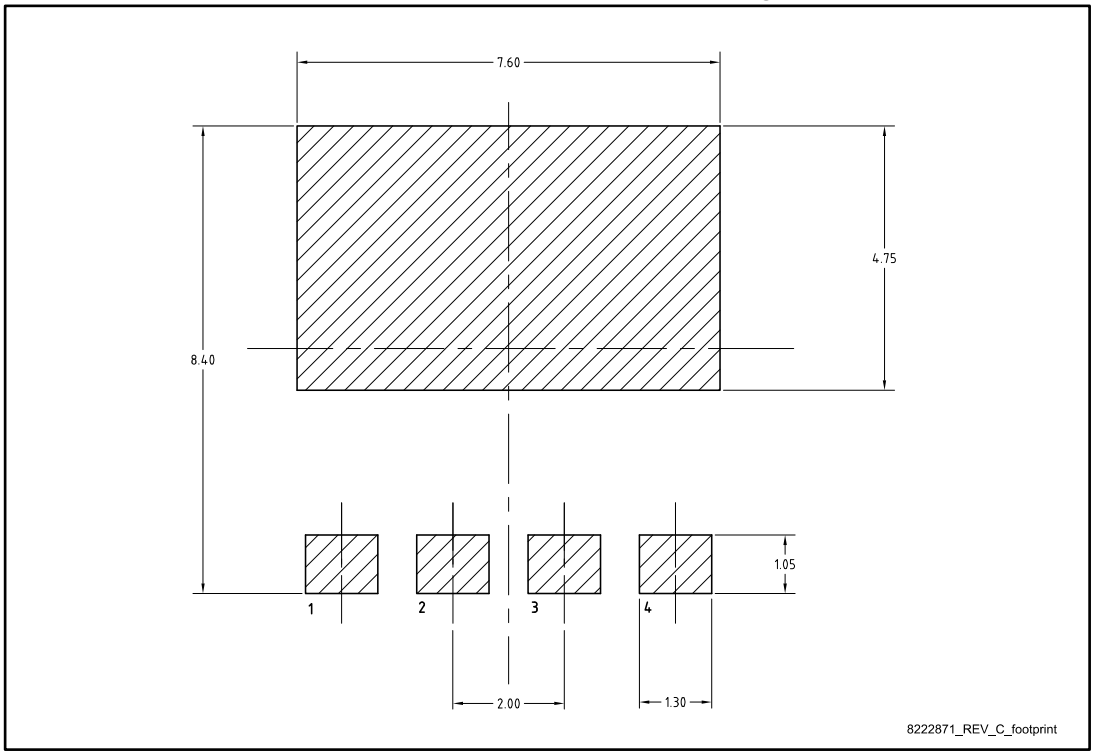


Table 8: PowerFLAT™ 8x8 HV mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	0.75	0.85	0.95
A1	0.00		0.05
A3	0.10	0.20	0.30
b	0.90	1.00	1.10
D	7.90	8.00	8.10
E	7.90	8.00	8.10
D2	7.10	7.20	7.30
E1	2.65	2.75	2.85
E2	4.25	4.35	4.45
e		2.00	
L	0.40	0.50	0.60

Figure 21: PowerFLAT™ 8x8 HV drawing



All dimensions are in millimeters.

4.2 PowerFLAT™ 8x8 HV packing information

Figure 22: PowerFLAT™ 8x8 HV tape

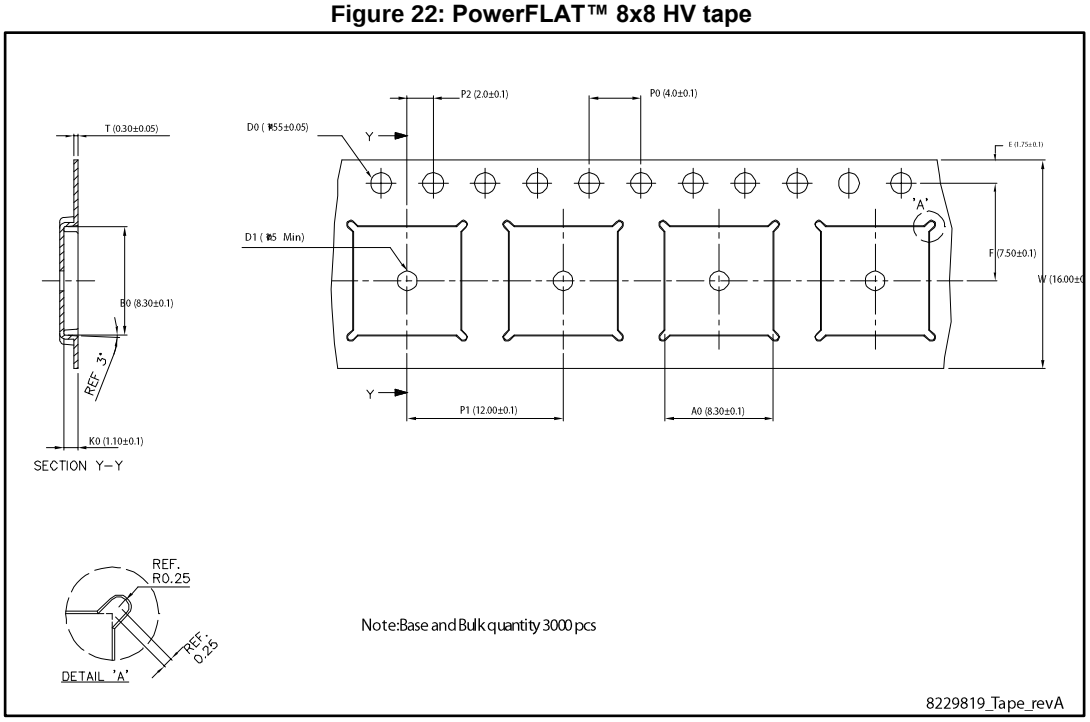


Figure 23: PowerFLAT™ 8x8 HV package orientation in carrier tape

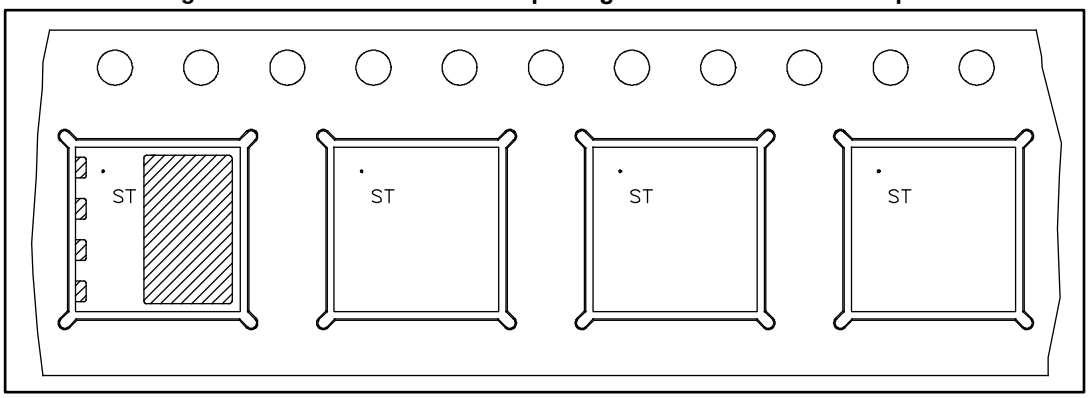
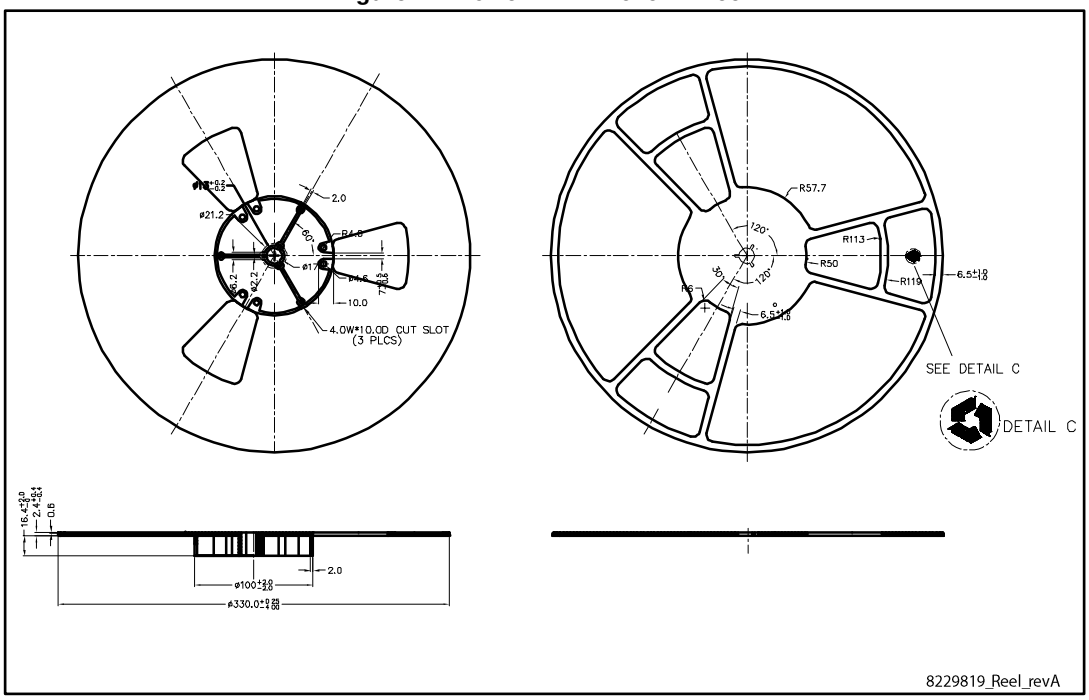


Figure 24: PowerFLAT™ 8x8 HV reel



5 Revision history

Table 9: Document revision history

Date	Revision	Changes
14-May-2012	1	First release.
25-Jan-2013	2	-Modified ID value and note 1 on first page -Modified: I_D, P_{TOT}, I_{AR} values, and note1, 4 on Table 2 -Modified: Rthj-case value on Table 3 -Modified: $R_{DS(on)}$ on Table 4 -Modified: typical values on Table 5 and 6 -Modified: typical and max values on Table 7 -Inserted: Section 2.1: Electrical characteristics (curves) -Document staus promoted from preliminary data to production data.
09-Oct-2015	3	Updated title, features and description Text and formatting changes throughout document. Updated *Section 1: "Electrical ratings"*and *Section 2: "Electrical characteristics"* Changes according to PCN9187: Updated package silhouette and figure *Figure 1: "Internal schematic diagram"* on cover page. Updated *Section 4.1: "PowerFLAT™ 8x8 HV package information"*.

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